Se	arch	Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/766,359	ZHOU ET AL.	
Examiner	Art Unit	•
Michael P. Stafira	2877	

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Class	Subclass	Date	Examiner	
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Class	Subclass	Date	Examiner
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	d See East n Report	4/26/2006	MPS

SEARCH NOT (INCLUDING SEARCH		
	DATE	EXMR
East	4/26/2006	MPS
NPL	4/26/2006	MPS
Inventor Search (Palm)	4/26/2006	MPS
PLUS	4/26/2006	MPS
IEEE Explore	4/26/2006	MPS
356/128-137	4/26/2006	MPS
entire patent class/subclass	4/26/2006	MPS